

**Notice of References Cited**

Application/Control No.

10/673,698

Applicant(s)/Patent Under  
Reexamination  
LEE ET AL.

Examiner

PONNOREAY PICH

Art Unit

2435

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0007407	01-2002	Klein, John Raymond	709/225
	B	US-			
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